Addition of Ba₂TiSi₂O₈ to manganese-doped barium titanate: effect on oxygen diffusion and grain-boundary composition

J. WEISS,* G. ROSENSTEIN

Philips Forschungslabor, Aachen, West Germany

The effect of barium titanium silicate additions to pure and manganese-doped barium titanate was studied by high-temperature conductivity and analytical electron microscopy. The results show that this addition precipitates during cooling as a second crystalline phase with only a small amount of amorphous phase left in a few grain boundaries. The secondary crystalline phase incorporates excess manganese left from the heterogeneous doping of barium titanate.

1. Introduction

The use of nickel electrodes in ceramic multilayer capacitors based on barium titanate requires that they are sintered under a reducing atmosphere. This necessitates the use of acceptor dopants in order to maintain the insulating state of the BaTiO₃ dielectric according to the defect chemistry [1–4]. The use of manganese as an acceptor has been described in a number of papers [2, 4–7]. A smooth temperature dependence of the relative permittivity, ε_r , requires a heterogeneous distribution of the dopant [8, 9].

On the other hand, manganese accumulations in the grain boundaries formed by locally exceeding the solubility, should be avoided, because they are suspected to be of higher conductivity. Thus the solubility limit of manganese in BaTiO₃ has to be determined. Earlier investigations only used up to 2 mol % [2, 10] without showing a solubility limit, while another paper reports higher concentrations with partial transformation to hexagonal BaTiO₃ again without reporting a solubility limit [5].

In order to avoid such manganese accumulations, it seemed of advantage to add small amounts (< 3 wt %) of Ba₂TiSi₂O₈ (BTS) to the BaTiO₃ matrix. The use of such silicate additions has been described in three earlier works [11–14]. Here it should serve two purposes:

1. BTS should "buffer" excess amounts of manganese by incorporating it into a second phase of either amorphous or crystalline nature.

2. BTS should aid sintering in order to support the heterogeneity of the dopant distribution by lowering the sintering temperature.

The following experiments should solve these questions. First, the reactions and the thermodynamics of such mixtures are evaluated by reacting $Ba_2TiSi_2O_8$ with $BaMnO_3$ and $MnSiO_3$ with $BaTiO_3$. This should serve as a simulation of possible reactions in the grain boundaries. DTA investigations should exploit the effect of composition and atmosphere for the melting temperature. Second, the solubility of manganese in BaTiO₃ under equilibrium conditions, is determined by measuring the Curie Point, T_c , in BaTiO₃ ceramics with increasing amounts of manganese. Finally, the microstructure of such a BaTiO₃ matrix with BTS additions should be evaluated on a macroscopic scale by high-temperature four-point conductivity measurements. These can reveal a distinct rise in the slope of the $\ln S - 1/T$ line due to the softening point of the amorphous phase, when a large fraction of the grain boundaries contains a thin amorphous second phase. In addition, such an amorphous phase alters the bulk diffusivity of oxygen. This can be tested by measuring the time response upon a change in pO_2 . Both types of conductivity measurement are done with BaTiO₃ and with BaTiO₃ containing BTS for comparison. Such macroscopic measurements seemed necessary, because even when an amorphous grain-boundary phase is detectable by analytical electron microscopy (AEM), no safe statement can be made, whether it is distributed equally over all grain boundaries or not.

On a microscopic scale this question should be checked by AEM, using dark-field imaging and scanning transmission electron microscopy (STEM) mode in combination with energy dispersive X-ray analysis (EDAX) analysis.

2. Experimental procedure

2.1. Powder preparation

The reactions between $BaMnO_3$ and $Ba_2TiSi_2O_8$, as well as the solubility limit of manganese in $BaTiO_3$, were studied with powders prepared by mixed oxides, with 1 h mixing in agate jars, calcining (15 h, 1150° C, air), and milling for 2 h in agate jars under hexanol. The BTS-type compositions were prepared by mixing and spray-drying the appropriate amounts of oxides and carbonates. They were calcined at 1050 or 1100° C for 50 h in order to achieve thorough reaction. After roller milling for 1 h with ZrO_2 media, these powders were attritor milled for 2 h to obtain the smaller par-

*Present address: Renker GmbH, Hausener, Weg. D-7800, Frieburg, West Germany.

TABLE I Composition, raw materials and powder analysis data.

Composition	BET (m ² g ⁻¹)	d ₅₀ (μm)	AAS analysis (wt %)			
			Mn	Si	Zr	Ca
Ba ₂ TiSi ₂ O ₈	15.8	-				
$Ba_1Ca_1 I I$						
$S_{1_2}Mn_{0.05}O_{8.1}$	2.2	-				
(= BCISM)	105					
$Ba_{1.5}Ca_{0.5} I1S1_2O_8$ (= G5)	16.5	-	n.d. =	= below	detect	ability
$Ba_{102.5}Ti_{100.6}Mn_1O_x$	5.5	0.56	0.22	0.04	0.24	n.d.
$Ba_{103.75}Ti_{100.6}Mn_2O_x$ (P8.5)	9.8	0.35	0.45	0.04	0.48	n.d.
$Ba_{105}Ti_{100.6}Mn_3O_x$	7.1	0.51	0.72	0.05	0.29	n.d.
from: Tam HPB, high-puri Ba(Ac) ₂ Alt $Mn(Ac)_2 \cdot 4H_2O$ Alt	ty BaTiO ₃ , a Products a Products	, Tam,	Niagar	a Falls,	, USA	urou
The BaTiO ₃ materia	s listed in	Table I	I were	prepare	ed from	1:
BaCO ₃ Mer	ck					
TiO ₂ Kro	nos					
MnCO ₃ · xH_2O Mer N ₂ /5% H ₂ at 1350° C	rck, x wa C, measurii	s detern ng the v	nined b weight l	oy treat oss.	ing in c	iry
The silicates were pr	epared from	n:				
TiO ₂ Un	itane	E	BaCO ₃ I	Merck		
SiO ₂ Me	erck					
$Ca(Ac)_2$ Alt	a Products	:				
$Mn(Ac)_2 \cdot 4H_2O$ Alf	a Products					

ticle size necessary to achieve a better dispersion of BTS in the grain boundaries. The dried powders were then pressed into bars or pellets and fired as for the materials described below.

The powders for the conductivity measurements and for the TEM/STEM-EDAX analyses were prepared from high-purity BaTiO₃ Tam HPB (TAM, Niagara Falls, New York, USA). The doping with manganese was achieved by dissolving the appropriate amounts of manganese acetate and barium acetate (MnAc₂ and BaAc₂), in distilled water and adding it to a slurry of BaTiO₃ (300 g BaTiO₃ in 2000 cm³ H₂O). BaAc₂ served to maintain an A/B lattice site ratio in BaTiO₃ of between 1.01 and 1.005 in the final product in order to inhibit grain growth (taking into account the average 0.5 wt % ZrO₂ wear from attritor milling). This mixture was stirred for 5 min and then spraydried. The BaTiO₃ powders were calcined at 1150° C for 2 h in air. The compositions and the powder analysis data are listed in Table I.

These powders were then roller milled for 1 h using 1000 cm^3 of 2 cm ZrO_2 media on 400 g powder in porcelain jars under H₂O to which $200 \text{ cm}^3 0.1 \text{ N}$ oxalic acid was added to inhibit formation of water-soluble Ba(OH)₂. Then the slurry and media were transferred to a plastic bottle and milled for 1 h on a vibration mill. The powder was dried and sifted before attritor milling. This was done using 120 g powder and 1200 g 3 mm ZrO₂ media for 90 min. Again 100 cm³ 0.1 N oxalic acid were added to inhibit Ba(OH)₂ formation. The BaTiO₃ powders were milled for 90 min. After drying and sifting, the powder was heat treated for 1 h at 550°C to decompose the oxalic acid.

2.2. Preparation and sintering of samples for

conductivity and microstructure analysis In order to obtain larger samples for conductivity measurements, foils were stacked, pressed and cut. Mixing of manganese-doped BaTiO₃ with BTS was usually done by preparing the slurry for foil casting by treating the slurry with the organic binder system consisting of a wetting agent, solvent, dispersion agent and plastisizer as described previously [15, 16]. Foil casting was done by the doctor blade process. The foils were sectioned and cut. For most of the present investigations, wafers were made by stacking up to 50 layers of tape, which were subsequently pressed to form monolithic bodies. Then the binder was burnt out by slowly heating (16h ramp) in air to 355° C.

All samples were sintered in $MoSi_2$ heated pipe furnaces in $N_2/0.2\%$ H₂ saturated with water vapour

TABLE II Composition, firing conditions and phase analysis of silicates and samples for the detection of the manganese solubility. These materials were prepared by the mixed oxide method

Composition	Sintering conditions			T _c	Phase analysis
	T (° C)	<i>t</i> (h)	Atm.	(°C)	X-ray diffr.
Tam HPB	1300	1	N ₂ 0.2% H ₂	121	t
Baigo Tijo Mno sO.	1350	4	FMG	106	t
220100 2 1010.5 - X	1350	4	air	119	t
Barro Tiro Mn O.	1350	4	FMG	104	t
	1350	4	air	119	t
Bayon Tiyon MnoO	1350	4	FMG	79	t
$2 = 100 \times 101 - 102 - 3$	1350	4	air	121	t
	1450	4	FMG	112	t + h
Bain Tim Mn.O.	1450	4	FMG	79	t + h
Ba_{104} Ti ₁₀₁ Mn_2O_{μ}	1350	4	FMG	89	t
2 - 100 - 1013 - X	1350	4	air	119	t
Balo Tim Mn.O.	1350	4	FMG	-	open porosity
Da101 x 100	1450	4	FMG	92	t + h
	1350	4	air	122	t
Balor Tilon Mn.O.	1450	4	FMG	79	t + h
$Ba_{104}Ti_{100}Mn_4O_{\mu}$	1350	4	FMG	74	t + h
100102	1350	4	air	123	t + h

FMG = $N_2/5\%$ H₂ moisted in H₂O at room temperature.

 $t = tetragonal (at room temperature) BaTiO_3.$

 $h = hexagonal BaTiO_3$ stabilized by manganese to room temperature.



Figure 1 Temperature dependence of the electric conductivity measured by the four-point method in flowing O_2 in BaTiO₃ with and without BTS additions. (**II**) Tam HPB, (*) Tam HPB + 2 wt % BCTSM, (**II**) P8.5, (x) P8.5 + 2 wt % G5. Compositions and sintering conditions: see Table III.

at room temperature. The sintering conditions are listed in Table II.

2.3. Powder analysis

The powders prepared from Tam HPB as well as BTS-type powders were measured for specific surface area (BET). For several powders we also measured the particle size and size distribution by a Micromeritics sedigraph by dispersing them with an ultrasonicator for 5 min in H₂O, to which 0.5 wt % Na₂HPO₄ was added. The manganese content of several BaTiO₃ powders was analysed by atomic absorption spectroscopy (AAS). All these results are included in Table 1.

2.4. Analysis of phase composition and Curie temperature

Several specimens were analysed by X-ray diffraction for phase composition. These results are included in Table II. The solubility of manganese was checked by measuring the Curie point, T_c , of samples sintered at 1350°C or higher, for 4 h in N₂/5% H₂ also saturated by water vapour at room temperature. For comparison, identical compositions were sintered under otherwise identical conditions in air. The pellets were then vapour coated with NiCrAu to apply electrical contacts and measured on a Hewlett Packard bridge

TABLE III Activation energy of the conductivity as determined from the Arrhenius plot of $\ln \sigma - 1/T$ by a least squares fit

Composition (sintered in moist $N_2/0.2\%$ H ₂)	Sintering temperature (1 h) (° C)	Activation energy (eV)
Tam HPB	1260	1.6
Tam HPB + 1 wt % BCTSM	1260	1.1
Tam HPB + 2 wt % BCTSM	1260	0.6
Tam HPB + 4 wt % BCTSM	1260	0.8
Tam HPB + 8 wt % BCTSM	1260	1.0
$Ba_{102.5}Ti_{100.6}Mn_1O_x$	1350	1.1
$Ba_{103,75}Ti_{100,6}Mn_2O_x$ (P8.5)	1175	1.2
P8.5 + 1 wt % G5	1175	1.2
P8.5 + 2 wt % G5	1175	1.3
$Ba_{105}Ti_{100.6}Mn_3O_x$	1350	1.5
$Ba_2TiSi_2O_8$ (sint. in O_2)	1410	7.0

TABLE IV Diffusion constants estimated from the time response upon change in p_{O_2} from 1 to 0.1 bar (out) and from 0.1 to 1 bar (in). These values may be compared to $D_0^{BT} = 5700 \exp{(-23780/T)}$ (cm² sec⁻¹) from [16, 17]. The sintering conditions of the materials listed here are identical to those of Table III

Composition	Temperature	D _{out}	D _{in}
	(° C)	$(\mathrm{cm}^2\mathrm{sec}^{-1})$	$(\mathrm{cm}^2\mathrm{sec}^{-1})$
Tam HPB	810	6.9×10^{-5}	_
	905	1.5×10^{-4}	6.6×10^{-5}
	998	2.0×10^{-4}	4.2×10^{-4}
Tam HPB + 1 wt %	815	6.6×10^{-5}	_
BCTSM	908	1.5×10^{-4}	5.1×10^{-6}
	995	1.3×10^{-4}	1.7×10^{-4}
Tam HPB + 8 wt %	815	4.5×10^{-5}	1.4×10^{-5}
BCTSM	907	5.3×10^{-5}	1.0×10^{-5}
	995	6.3×10^{-5}	4.0×10^{-5}
$Ba_{102.5}Ti_{100.6}Mn_1O_x$	990	8.2×10^{-5}	2.4×10^{-5}
$Ba_{103.75}Ti_{100.6}Mn_2O_x$	1018	2.5×10^{-4}	1.5×10^{-4}
(P8.5)			
P8.5 + 1 wt % G5	1001	8.3×10^{-5}	4.7×10^{-5}
P8.5 + 2 wt % G5	1002	6.2×10^{-5}	5.3×10^{-5}
$Ba_{105}Ti_{100.6}Mn_3O_x$	985	8.6×10^{-5}	_

4274 A from -60 to 150° C at 1 kHz, 1 V in order to determine the $T_{\rm c}$ value.

2.5. Conductivity measurements

First, the high-temperature measurements of the electrical conductivity were performed in a canthal wound furnace in flowing oxygen. The oxygen partial pressure, p_{O_1} , was controlled by a ZrO_2 cell. The temperature was measured using an Ni/NiCr thermocouple stuck close to the sample. The conductivity was determined by the four-point method, for which the sintered dummy wafers were cut into bars of 2.0 cm \times 0.5 cm and 0.2 cm thick. Notches to fix platinum contact wires were drilled alongside the bars at 0.1, 0.5, 1.5 and 1.9 cm on both sides. A detailed description of the experimental apparatus was given previously [17, 18]. In order to check for pure ohmic behaviour, the current was increased stepwise. The conductivity was calculated from the detected voltage by a least squares fit. All samples obeyed the ohmic behaviour well. The measured temperature range in O₂ at ambient pressure was 700 to 1100° C. This served to give the $\ln \rho - 1/T$ diagram shown in Fig. 1, from which the activation energy was determined by a least squares fit. These results are listed in Table III.

Second, dynamic measurements were made by switching the gas flow between O_2 and $N_2/10\% O_2$ following the change of conductivity over time. For this the gas flow of both gases was set at the same level $(0.2 \ 1 \text{min}^{-1})$. All samples were measured at 1000° C; some selected ones were additionally measured at 800 and 900° C. The percentage conductivity change over time then served to estimate the diffusion constant by a least squares fit of the function [19]

$$\ln (1 - C/C_0) = A + B t$$
 (1)

where C is the percentage change in voltage at time t, while C_0 is the change at infinity, for which in our case 5 to 10 min always proved to be sufficient. Using the sample thickness, h, the diffusion constant, D, at the temperature, T, can then be approximated by

$$D = (h^2/\pi^2)B \tag{2}$$

The results are listed in Table IV.

2.6. Analytical electron microscopy investigations

For TEM/STEM microscopy the materials were cut by a diamond saw in to thin sections. These were then mechanically thinned to about $30 \,\mu m$ by mechanical grinding. Argon-ion milling was used to complete the thinning process. For the analytical investigations we used a Philips 400 T electron microscope, equipped with a scanning and energy dispersive analysis unit. The TEM mode was used for bright- and dark-field images. Dark-field images, with the objective diaphragm set on the amorphous ring of the corresponding diffraction pattern, were taken to reveal amorphous phases. STEM-EDAX digital linescans served to investigate the distribution of the elements silicon, manganese and calcium over particular areas. The STEM image with the marked location of the linescan shows relative characteristic X-ray intensities of these three elements along this scan. Each intensity was normalized by the sum of all measured intensities to reduce the influence of varying sample thickness, surface topography and primary electron intensity. Grain boundaries are drawn into these diagrams as vertical bars.

3. Results and discussion

3.1. Solubility of manganese in BaTiO₃ and reaction between excess manganese and BTS under various conditions

Fig. 2 shows the effect of manganese on T_c in BaTiO₃: while under reducing atmosphere, a linear decrease up to 2 mol % and 70° C is observed, oxidizing sintering alters this pattern such that hardly any change occurs. This is due to the absence of a significant concentration of oxygen vacancies, V_0^{BT} . The slope and the stable $T_{\rm c}$ upon sintering in air is found to be in agreement with results reported previously [4, 20]. Although from the thermodynamic point of view the solubility limit of manganese in BaTiO₃ may alter with p_{O_2} , such a change should be minimal compared to the absolute manganese content investigated here. Exceeding the solubility of manganese can lead to the formation of hexagonal BaTiO₃ in agreement with the results of Herbert [5]. Glaister and Kay [21] reported a lowering of the cubic to hexagonal conversion in BaTiO₃ in the



Figure 2 Solubility of manganese in BaTiO₃ sintered in (\bullet) moist N₂/5% H₂ and (O) air. For A/B ratio and sintering conditions see Table II.



Figure 3 Stabilization of large needle-shaped hexagonal BaTiO₃ by manganese. Composition: $Ba_{104} Ti_{101} Mn_2O_x$, sintered at 1450°C, 4 h in moist $N_2/5\%$ H₂.

presence of 10 mol % manganese down to 1100° C under reducing conditions. In the present investigation, the hexagonal BaTiO₃ modification could be identified as big needle-shaped crystals in the microstructure (Fig. 3) when sintered above 1300° C. The phase relation between the extreme compositions BaTiO₃ and BaMnO₃ is not reported in literature and was not a topic of the present investigation.

The X-ray diffraction analysis of mixtures of both $Ba_2TiSi_2O_8$ with $BaMnO_3$ and $BaTiO_3$ with $MnSiO_3$ gives the following reactions, when mixtures of these prereacted starting compounds are fired together.

$$Ba_{2}TiSi_{2}O_{8} + BaMnO_{3}$$

$$\xrightarrow{O_{2} 1150^{\circ}C} BaTiO_{3} + Ba_{2}TiSi_{2}O_{8} ss (Mn)$$

$$\xrightarrow{O_{2} 1250^{\circ}C} melts$$

$$\xrightarrow{FMG 1150^{\circ}C} BaTiO_{3} + Ba_{2}TiSi_{2}O_{8} ss (Mn)$$

$$\xrightarrow{FMG 1250^{\circ}C} BaTiO_{3} + Ba_{2}TiSi_{2}O_{8} ss (Mn) (1)$$

$$BaTiO_{3} + 2MnSiO_{3}$$

$$\xrightarrow{O_{2} 1150^{\circ}C} melts$$

$$\xrightarrow{FMG 1150^{\circ}C} Ba_{2}TiSi_{2}O_{8} + MnTiO_{3}$$

$$\xrightarrow{FMG 1200^{\circ}C} melts (2)$$

FMG = $N_2/5\%$ H₂ saturated with water vapour at room temperature; ss = solid solution, see text. Only on the left-hand side is this reaction expressed quantitatively. On the right-hand side the complexity of the X-ray patterns and the fact that in all cases minor, unidentifiable peaks occurred, did not allow a quantitative evaluation. These unidentified phases will, however, not play a role for smaller amounts of BTS added to BaTiO₃. In such compositions they were never detected, but only BaTiO₃ and BTS were found.

Reaction 1 shows that under reducing conditions, excess manganese (forming $BaMnO_3$ in the extreme case) will be incorporated into BTS. A phase $Ba_2MnSi_2O_8$ is known from the literature [22]. Its X-ray pattern shows a striking similarity to that of BTS and does not allow a clear separation of these



Figure 4 Time response of the change in conductivity upon switching the gas flow from O₂ to N₂/10% O₂. At 810° C: (O) Tam HPB, (x) Tam HPB + 1 wt % BCTSM, (**D** Tam HPB + 8 wt % BCTSM. At 995° C: (**O**) Tam HPB, (*) Tam HPB + 1 wt % BCTSM, (**\Phi**) Tam HPB + 8 wt % BCTSM. For compositions and sintering conditions see Table III.

phases: the lattice parameters given [22] (a =0.381 nm, c = 0.537 nm, tetragonal structure differ little from those of $Ba_2 TiSi_2O_8$ (a = 0.852 nm, c = 0.521 nm, tetragonal [23]). This case is indicated as BTS solid solution (Mn) in the reactions above. Although such a solid solution between these two related phases (exchanging manganese for titanium) was not investigated in detail, it does seem likely. The reason is the similarity of the structures and lattice constants [22-24]. In any case BTS does show some solubility for manganese as detected by STEM/EDAX measurements described below. Reaction 2 serves as a cross check for the opposite direction of Reaction 1, although of course its total composition is not identical to that of Reaction 1, which is the reason why MnTiO₃ is found in addition to BTS.

Replacement of part of the barium in BTS by cal-

cium was checked by X-ray diffraction and always yielded BTS without any other phase. BTS itself does not change the solubility limit of manganese in BaTiO₃ in a visible manner. The T_c values of all materials were unchanged, when BTS was added.

DTA runs of mixtures of BaTiO₃ with BTS showed for manganese-free compositions a melting range of 1240 to 1300° C and for manganese-containing compositions 1180 to 1240° C. Calcium substituted in Ba₂TiSi₂O₈ for barium did not change the melting range in a detectable manner.

In these compositions, consisting of BaTiO₃ and BTS, variations of the p_{O_2} of the atmosphere (moist N₂ 5% H₂ or air) did not show a different range of melting and phase composition. T_c and conductivity measurements of Tam HPB with addition of different amounts of a calcium, manganese containing BTS, revealed a partial acceptor doping from such a BTS during sintering. The doping content in BaTiO₃, of course, depends on the composition and amount of BTS added as well as on the sintering temperature.

3.2. Conductivity measurements

3.2.1. Some theoretical considerations

In BaTiO₃ at high temperatures (> 600° C) the conduction is of an electronic nature. Changes of the external p_{O_2} lead to a change in V_0^{BT} , so that dynamic measurements are controlled by the oxygen vacancy diffusion. For static measurements only the defect concentration plays a role. All this is well documented [1–4, 25, 26].

In an amorphous glassy phase, on the other hand, the conduction is governed by ionic diffusion, i.e. in silicate-rich glasses normally by the diffusion of oxygen ions or cations. So first of all the softening point of such a glass should change the slope of the



Figure 5 (a) Diffraction pattern (camera length L = 1600 mm) and (b) dark-field image taken by setting the objective aperture on the amorphous ring. Material: Tam HPB + 2 wt % BCTSM (for composition and firing see Table III). The dark-field image does not show any amorphous area.







conductivity, when plotted against the reciprocal temperature. Above a certain temperature the conductivity will no longer follow a simple Arrheniustype behaviour due to other diffusion mechanisms that start to participate. Owing to the different activation energies, the temperature dependence of the conductivity should be different, when an amorphous grain-boundary phase is present and wets the grain boundaries.

Secondly, the presence of such an amorphous phase can alter the overall diffusion coefficient. The response time upon changes in p_{O_2} may vary considerably. For this overall diffusion coefficient the diffusivity of the amorphous phase is of importance. As it is strongly

Figure 6 P8.5 + 1 wt % G5 (see Table III): (a) diffraction pattern (L = 1600 mm) and (b) dark-field image showing a grain surrounded by some amorphous phase. (c) One of the grain boundaries in a dark-field image with a thin amorphous layer.

composition dependent (at 1000° C, D_0^{glass} ranging from 5 × 10^{-5} cm² sec⁻¹ for 30% alkaline-containing silicate to 10^{-14} cm² sec⁻¹ for pure SiO₂ glass [27]), only a rough estimate for the diffusion constant can be made. Thereby possible charge transport by cationic species (in the present case this would mainly be Ba^{2+} . because silicon, manganese and titanium as network formers are not likely to participate) can be neglected. As in these measurements the atmosphere was only varied between O_2 and $N_2/10\% O_2$ and only the change in conductivity was detected (where the cations would give a constant contribution due to the small change in p_{O_2}), only oxygen diffusivity needs to be considered. The oxygen in glass can diffuse either as molecular oxygen or, as would be the case here, with the BaTiO₃ matrix, by network diffusion as ionic O^{2-} [28]. Taking into account these facts, the oxygen diffusion of such an amorphous phase will be several orders of magnitude lower than that in BaTiO₃ and thus should have a marked effect on overall diffusivity.

3.2.2.Temperature dependence of conductivity

The temperature dependence of the conductivity of BaTiO₃ and BaTiO₃-BTS mixtures in Fig. 1 shows a linear behaviour without any distinct bend. The addition of manganese to BaTiO₃ in BTS-free BaTiO₃ diminishes the activation energy at first and then increases it (Table III). This may be caused by exceeding the solubility limit of manganese in BaTiO₃ (~2 at. %, see Section 3.1). All activation energies, however, are within a range measured for diffusion in BaTiO₃ ceramics [17, 18]. It must be emphasized, that our values for the activation energies, as well as for the



Figure 7 P8.5 (see Table III): (a) diffraction pattern (L = 1600 mm) and (b) dark-field image showing second phase microcrystals presumably embedded in amorphous phase. In this material the silica content is a result of wear by attritor milling.

diffusion constants, may not be considered as accurate material values themselves, due to the heterogeneous doping of the material, but serve to evaluate the microstructure. Expansion measurements of Tam HPB containing different levels of BTS carried out in air only revealed a very weak indication of a softening point at about 850° C, when the composition was very rich (about 30 mol %) in BTS. This also indicates the absence of significant amounts of an amorphous phase.

3.2.3.Diffusivity of oxygen upon changes in p_{O_2}

The time response of the change of the voltage upon change in p_{O_2} does not show any difference between silicate-containing and silicate-free material either. Fig. 4 shows two BTS-free and two BTS-containing materials for comparison. A percentage representation for the conductivity change was chosen to standardize the conductivities measured and make them comparable.

The diffusion coefficients estimated from these data are in the range of the diffusion coefficients determined for pure BaTiO₃ or slightly larger [17, 18]. This contradicts the presence of a continuous amorphous grain-boundary layer. The experimental evidence for the absence of an amorphous grain-boundary layer is also supported by the fact that both types of materials behave similarly at all three temperatures tested. This would require similar activation energies for the diffusion constants in both phases. Taking into account their different structure, this is unlikely. Assuming the detected crystalline nature of BTS, its amount is below the sensitivity level which would have any visible effect on the bulk diffusion in BaTiO₃.

3.3. TEM, STEM and EDAX analysis

Numerous papers describe the methods applicable for



Figure 8 (a) STEM image and (b) EDAX line scan, revealing the accumulation of manganese and silicon in submicrometre-sized grains in the grain boundaries (material: P8.5 + 1 wt % G5) (b) (\bullet) Si, (x) Ca, (\circ) Mn, $V = 50\,000$, $S = 10\,\text{nm}$.

the detection of thin amorphous grain-boundary layers in ceramic materials [29-31]. Because of the number of specimens to be investigated, dark-field images with the corresponding diffraction patterns were used to detect the presence or absence of an amorphous phase. Figs 5 to 7 show examples of this investigation, which again included BTS-free and BTS-containing material. The results are identical for both. In both types of material minimal amounts of amorphous phase can be found in a few grain boundaries. When such an amorphous layer is present in other types of materials like silicon nitride sintered with oxide additives, it would have a thickness of $\geq 2 \text{ nm}$ [30-32]. It was not possible in any case, to detect an amorphous grain-boundary layer as a continuous network on a large number of BaTiO₃ grains. The majority of the grain boundaries did not show any amorphous phase in the dark-field image, even when the grain boundaries were aligned exactly parallel to the electron beam. In addition, only in one case was it possible to detect a large number of very fine microcrystals in a triple point. From the diffraction pattern as well as the dark-field image, it appears that some amorphous phase may still be present between these microcrystals (Fig. 7). In no case did we observe large pools of amorphous phase in triple points. The fact that even in BaTiO₃, where no BTS was added, traces of an amorphous phase can be found, stems from the SiO₂ content, used as a sintering aid in the fabrication of the ZrO₂ attritor milling media (silicon content in the ZrO₂ media as detected by AAS; 4.61 wt %).

The STEM-EDAX line scan in Fig. 8 shows an enrichment of manganese and silicon in a small grain $(d \approx 0.2 \,\mu\text{m})$ in a triple point between larger BaTiO₃ grains $(d \approx 1 \,\mu\text{m})$. This supports the finding of the reaction study, that BTS reacts with the excess manganese in manganese-rich BaTiO₃ and incorporates it into its structure on titanium sites. Such microcrystals showing a high relative intensity of silicon and manganese have been detected in a number of locations. The calcium intensity had uniform distribution and did not show any enrichment in the silicate.

In order to estimate how much amorphous phase would be needed to form a uniform layer of 2 nm in all grain boundaries, we make the following estimation. The density of BTS, ρ_{BTS} (4.45 g cm⁻³ [23]), may be approximated as 4.0 g cm⁻³ in the amorphous state. With the density, ρ_{BT} , of BaTiO₃ taken to be 5.8 g cm⁻³, the layer thickness dx = 2 nm of the amorphous phase, and the average grain size for BaTiO₃ 1 μ m, the volume fraction, V_{gb} , of the amorphous phase is estimated according to the formula given by Saltikov [33]

$$V_{\rm gb} = 2 \,\mathrm{d}x/d_{\rm g} \tag{3}$$

which gives the weight fraction by using the densities

wt
$$\mathcal{V}_{gb} = V_{gb} \rho_{gb} 100 / (V_{gb} \rho_{gb} + V_{BT} \rho_{BT})$$
 (4)

This yields a value of 0.28 wt %. This theoretical estimation also shows that the amount BTS added should by far be sufficient to cover all grain boundaries. The fact that only a few grain boundaries and no triple

points show such an amorphous phase is an indication that in $BaTiO_3$ a strong tendency exists to crystallize such a silicate second phase.

4. Conclusion

The solubility of manganese in $BaTiO_3$ and the effect of BTS additions to manganese-doped $BaTiO_3$ were the focal points of the present study. Thereby a particular point of interest was, whether, after cooling, BTS forms a crystalline second phase or remains present as an amorphous grain-boundary phase. The results show:

1. Manganese is soluble up to $2 \mod \%$ in BaTiO₃ under conditions that allow a homogeneous doping distribution. Heterogeneous doping normally will lead to local enrichment of manganese in grain boundaries already with lower levels of manganese content.

2. BTS aids densification by forming a liquid phase above 1240°C. The exact melting temperature is determined by the composition: whereas partial replacement of barium by calcium in $Ba_2 TiSi_2O_8$ does not alter the melting point, manganese leads to a decrease of about 60°C.

3. BTS reacts with $BaMnO_3$, which may be present due to the high amount of manganese, exceeding the solubility limit of manganese in $BaTiO_3$ to form BTS ss, where manganese substitutes part of the titanium in $Ba_2TiSi_2O_8$. This is found by a direct reaction study as well as by STEM-EDAX analysis of manganese-rich $BaTiO_3$, to which BTS is added.

4. TEM diffraction and dark-field analysis yields only traces of an amorphous phase in a few grain boundaries. The presence of an overall amorphous grain-boundary layer may be ruled out, because BTS crystallizes after cooling.

5. High-temperature conductivity measurements in O_2 support this finding on a macroscopic scale. In addition, the conductivity does not show a bend when plotted against the reciprocal temperature, which otherwise should occur due to the softening point. Secondly, the time dependence upon changes in p_{O_2} does not show any effect when BTS is present.

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